

## MOSFET

### 600V CoolMOS™ CM8 Power Transistor

Built on Infineon's world-class super-junction MOSFET platform with an integrated fast body diode, making it suitable for a wide range of applications. It enables highest power density at lowest possible system cost with superior reliability. It is enhancing Infineon's WBG offering and the successor of the 600 V CoolMOS™ 7 MOSFET family.

### Features

- Best-In-Class SJ Mosfet Performance
- Address broad hard and soft switching applications with outstanding commutation ruggedness
- Integrated fast body diode and ESD protection
- .XT interconnection technology for best-in-class thermal performance

### Benefits

- Provides the best price performance ratio with Best-In-Class SJ Mosfet Performance
- Ease of use and shorter design in cycle
- Enable multiple topologies
- 14-42% lower  $R_{th}$  for improved thermal performance

### Potential applications

- Datacenter, AI server, Telecom Power Supply
- Micro and Residential Hybrid Inverter
- Portable and Residential Energy Storage, UPS
- EV Charging, Light electric vehicles, Electric Forklift
- High Voltage Solid State Power Distribution
- Home & Professional Tools
- Charger, Adapters, TV and Console SMPS

### Product validation

Qualified according to relevant JEDEC tests.

*Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.*

**Table 1** Key performance parameters

| Parameter            | Value | Unit |
|----------------------|-------|------|
| $V_{DS} @ T_{j,max}$ | 650   | V    |
| $R_{DS(on),max}$     | 55    | mΩ   |
| $Q_{g,typ}$          | 51    | nC   |
| $I_{D,pulse}$        | 148   | A    |
| $E_{oss} @ 400 V$    | 7.0   | μJ   |
| Body diode $di_F/dt$ | 1300  | A/μs |
| ESD class (HBM)      | 2     |      |

| Part number   | Package     | Marking  | Related links  |
|---------------|-------------|----------|----------------|
| IPLT60R055CM8 | PG-HDSOP-16 | 60R055C8 | see Appendix A |

TOLT

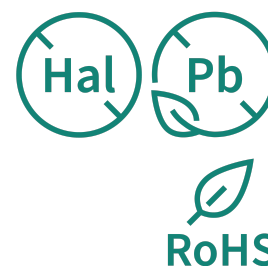
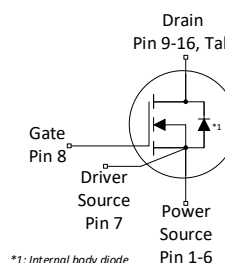
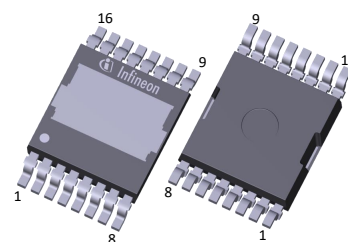




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# 1 Maximum ratings

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

**Table 2 Maximum ratings**

| Parameter                               | Symbol              | Values |      |      | Unit             | Note / Test condition                                                                                 |
|-----------------------------------------|---------------------|--------|------|------|------------------|-------------------------------------------------------------------------------------------------------|
|                                         |                     | Min.   | Typ. | Max. |                  |                                                                                                       |
| Continuous drain current <sup>1)</sup>  | $I_D$               | -      | -    | 48   | A                | $T_C = 25^\circ\text{C}$                                                                              |
| Continuous drain current                | $I_D$               | -      | -    | 30   | A                | $T_C = 100^\circ\text{C}$                                                                             |
| Pulsed drain current <sup>2)</sup>      | $I_{D,pulse}$       | -      | -    | 148  | A                | $T_C = 25^\circ\text{C}$                                                                              |
| Avalanche energy, single pulse          | $E_{AS}$            | -      | -    | 87   | mJ               | $I_D = 3.9\text{ A}$ ; $V_{DD} = 50\text{ V}$ ; see table 10                                          |
| Avalanche energy, repetitive            | $E_{AR}$            |        |      | 0.44 |                  |                                                                                                       |
| Avalanche current, single pulse         | $I_{AS}$            | -      | -    | 3.9  | A                | -                                                                                                     |
| MOSFET dv/dt ruggedness                 | dv/dt               | -      | -    | 120  | V/ns             | $V_{DS} = 0 \dots 400\text{ V}$                                                                       |
| Gate source voltage (static)            | $V_{GS}$            | -20    | -    | 20   | V                | static;                                                                                               |
| Gate source voltage (dynamic)           | $V_{GS}$            | -30    | -    | 30   | V                | AC ( $f > 1\text{ Hz}$ )                                                                              |
| Power dissipation                       | $P_{tot}$           | -      | -    | 278  | W                | $T_C = 25^\circ\text{C}$                                                                              |
| Storage temperature                     | $T_{stg}$           | -55    | -    | 150  | $^\circ\text{C}$ | -                                                                                                     |
| Operating junction temperature          | $T_j$               |        |      |      |                  |                                                                                                       |
| Extended operating junction temperature | $T_j$               | 150    | -    | 175  | $^\circ\text{C}$ | $\leq 50\text{ h}$ in the application lifetime                                                        |
| Mounting torque                         | -                   | -      | -    | -    | Ncm              | -                                                                                                     |
| Continuous diode forward current        | $I_S$               | -      | -    | 48   | A                | $T_C = 25^\circ\text{C}$                                                                              |
| Diode pulse current <sup>2)</sup>       | $I_{S,pulse}$       |        |      | 148  |                  |                                                                                                       |
| Reverse diode dv/dt <sup>3)</sup>       | dv/dt               | -      | -    | 70   | V/ns             | $V_{DS} = 0 \dots 400\text{ V}$ , $I_{SD} \leq 48\text{ A}$ , $T_j = 25^\circ\text{C}$<br>see table 8 |
| Maximum diode commutation speed         | di <sub>F</sub> /dt |        |      | 1300 | A/ $\mu\text{s}$ |                                                                                                       |
| Insulation withstand voltage            | $V_{ISO}$           | -      | -    | n.a. | V                | $V_{rms}$ , $T_C = 25^\circ\text{C}$ , $t = 1\text{ min}$                                             |

<sup>1)</sup> Limited by  $T_{j,max}$ .

<sup>2)</sup> Pulse width  $t_p$  limited by  $T_{j,max}$ .

<sup>3)</sup> Identical low side and high side switch with identical  $R_G$ .

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

| Parameter                                               | Symbol     | Values |      |      | Unit | Note / Test condition                                                                                                                                                                    |
|---------------------------------------------------------|------------|--------|------|------|------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
|                                                         |            | Min.   | Typ. | Max. |      |                                                                                                                                                                                          |
| Thermal resistance, junction - case                     | $R_{thJC}$ | -      | -    | 0.45 | K/W  | -                                                                                                                                                                                        |
| Thermal resistance, junction - ambient                  | $R_{thJA}$ | -      | -    | 62   | K/W  | device on PCB, minimal footprint                                                                                                                                                         |
| Thermal resistance, junction - ambient for SMD version  | $R_{thJA}$ | -      | 45   | 55   | K/W  | Device on 40 mm*40 mm*1.5 mm epoxy PCB FR4 with 6 cm <sup>2</sup> (one layer, 70 μm thickness) copper area for drain connection and cooling. PCB is vertical without air stream cooling. |
| Soldering temperature, wave- & reflow soldering allowed | $T_{sold}$ | -      | -    | 260  | °C   | reflow MSL1                                                                                                                                                                              |

### 3 Electrical characteristics

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

**Table 4 Static characteristics**

| Parameter                        | Symbol        | Values |       |       | Unit          | Note / Test condition                                                       |
|----------------------------------|---------------|--------|-------|-------|---------------|-----------------------------------------------------------------------------|
|                                  |               | Min.   | Typ.  | Max.  |               |                                                                             |
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | 600    | -     | -     | V             | $V_{GS} = 0\text{ V}$ , $I_D = 1\text{ mA}$                                 |
| Gate threshold voltage           | $V_{(GS)th}$  | 3.7    | 4.2   | 4.7   | V             | $V_{DS} = V_{GS}$ , $I_D = 0.44\text{ mA}$                                  |
| Zero gate voltage drain current  | $I_{DSS}$     | -      | -     | 1     | $\mu\text{A}$ | $V_{DS} = 600\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_j = 25^\circ\text{C}$  |
|                                  |               |        | 52.6  | -     |               | $V_{DS} = 600\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_j = 150^\circ\text{C}$ |
| Gate-source leakage current      | $I_{GSS}$     | -      | -     | 0.1   | $\mu\text{A}$ | $V_{GS} = 20\text{ V}$ , $V_{DS} = 0\text{ V}$                              |
| Drain-source on-state resistance | $R_{DS(on)}$  | -      | 0.046 | 0.055 | $\Omega$      | $V_{GS} = 10\text{ V}$ , $I_D = 18.2\text{ A}$ , $T_j = 25^\circ\text{C}$   |
|                                  |               |        | 0.101 | -     |               | $V_{GS} = 10\text{ V}$ , $I_D = 18.2\text{ A}$ , $T_j = 150^\circ\text{C}$  |
| Gate resistance                  | $R_G$         | -      | 6.2   | -     | $\Omega$      | $f = 1\text{ MHz}$                                                          |

**Table 5 Dynamic characteristics**

| Parameter                                                  | Symbol       | Values |      |      | Unit | Note / Test condition                                                                                             |
|------------------------------------------------------------|--------------|--------|------|------|------|-------------------------------------------------------------------------------------------------------------------|
|                                                            |              | Min.   | Typ. | Max. |      |                                                                                                                   |
| Input capacitance                                          | $C_{iss}$    | -      | 2245 | -    | pF   | $V_{GS} = 0\text{ V}$ , $V_{DS} = 400\text{ V}$ , $f = 250\text{ kHz}$                                            |
| Output capacitance                                         | $C_{oss}$    |        | 29   |      |      |                                                                                                                   |
| Effective output capacitance, energy related <sup>4)</sup> | $C_{o(er)}$  | -      | 87   | -    | pF   | $V_{GS} = 0\text{ V}$ , $V_{DS} = 0...400\text{ V}$                                                               |
| Effective output capacitance, time related <sup>5)</sup>   | $C_{o(tr)}$  | -      | 894  | -    | pF   | $I_D = \text{constant}$ , $V_{GS} = 0\text{ V}$ , $V_{DS} = 0...400\text{ V}$                                     |
| Turn-on delay time                                         | $t_{d(on)}$  | -      | 19   | -    | ns   | $V_{DD} = 400\text{ V}$ , $V_{GS} = 13\text{ V}$ , $I_D = 8.7\text{ A}$ , $R_G = 5.3\text{ }\Omega$ ; see table 9 |
| Rise time                                                  | $t_r$        |        | 6    |      |      |                                                                                                                   |
| Turn-off delay time                                        | $t_{d(off)}$ |        | 98   |      |      |                                                                                                                   |
| Fall time                                                  | $t_f$        |        | 7    |      |      |                                                                                                                   |

<sup>4)</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V

<sup>5)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400V

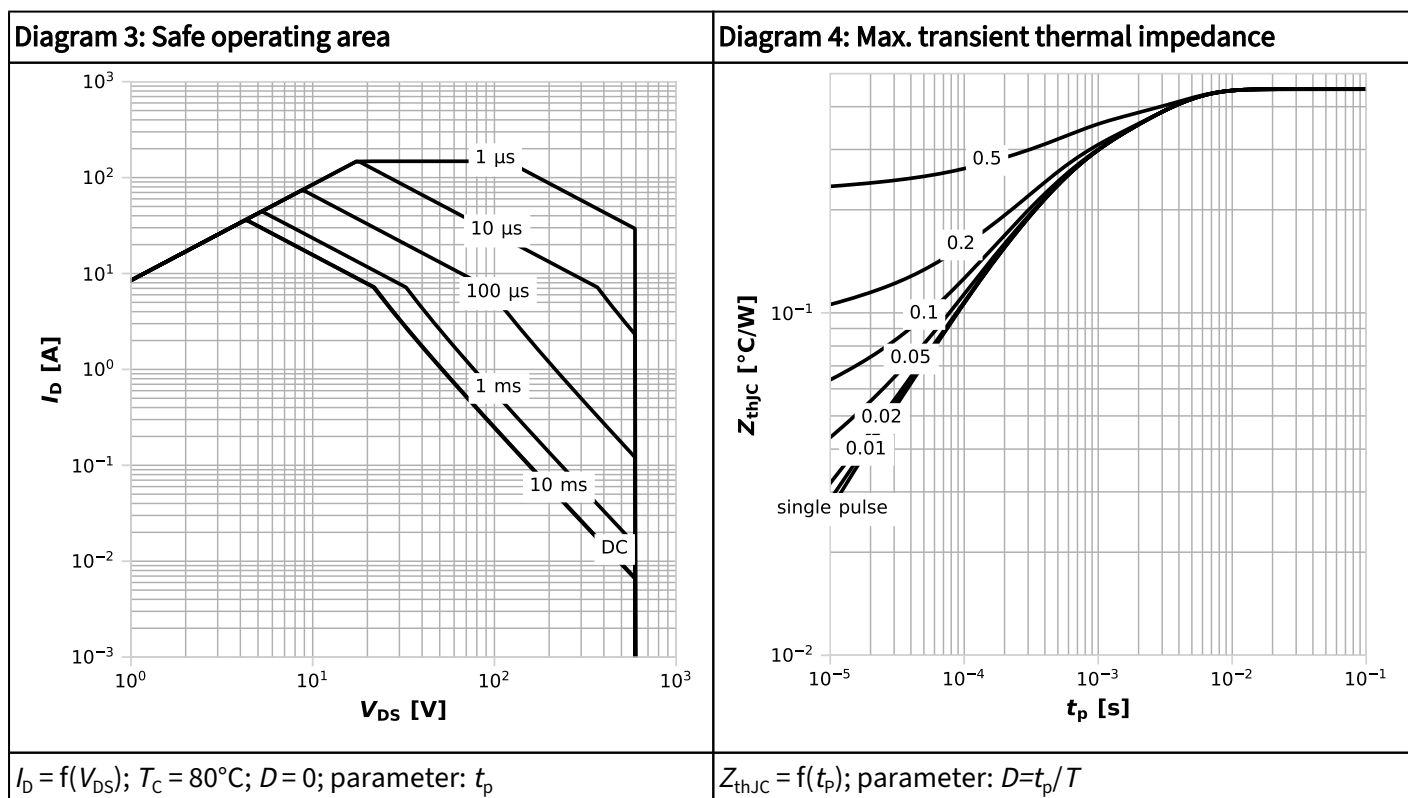
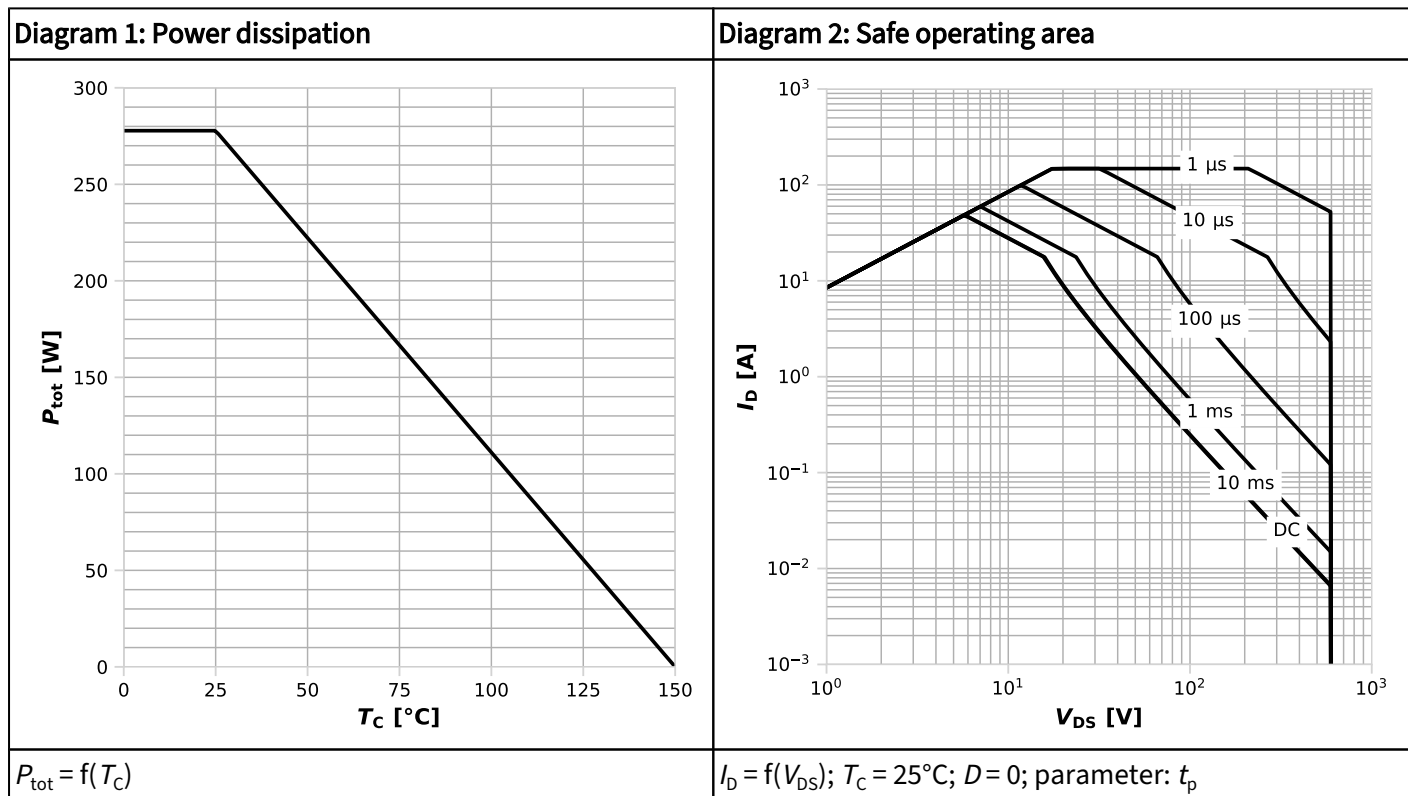
**Table 6 Gate charge characteristics**

| Parameter             | Symbol        | Values |      |      | Unit | Note / Test condition                                                               |
|-----------------------|---------------|--------|------|------|------|-------------------------------------------------------------------------------------|
|                       |               | Min.   | Typ. | Max. |      |                                                                                     |
| Gate to source charge | $Q_{gs}$      | -      | 14   | -    | nC   | $V_{DD} = 400\text{ V}$ , $I_D = 8.7\text{ A}$ , $V_{GS} = 0\text{ to }10\text{ V}$ |
| Gate to drain charge  | $Q_{gd}$      |        | 19   |      | nC   |                                                                                     |
| Gate charge total     | $Q_g$         |        | 51   |      | nC   |                                                                                     |
| Gate plateau voltage  | $V_{plateau}$ |        | 6.0  |      | V    |                                                                                     |

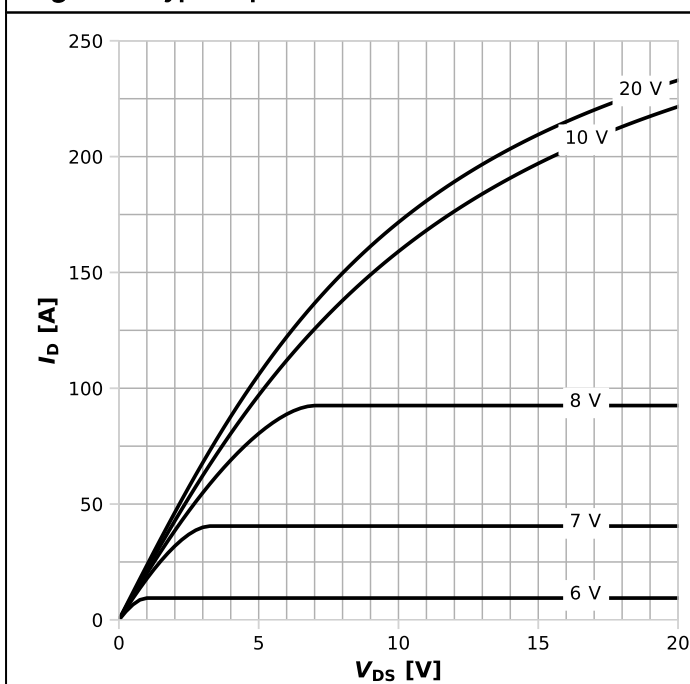
**Table 7 Reverse diode characteristics**

| Parameter                     | Symbol    | Values |       |      | Unit          | Note / Test condition                                                                               |
|-------------------------------|-----------|--------|-------|------|---------------|-----------------------------------------------------------------------------------------------------|
|                               |           | Min.   | Typ.  | Max. |               |                                                                                                     |
| Diode forward voltage         | $V_{SD}$  | -      | 0.9   | -    | V             | $V_{GS} = 0\text{ V}$ , $I_F = 8.7\text{ A}$ , $T_j = 25^\circ\text{C}$                             |
| Reverse recovery time         | $t_{rr}$  | -      | 98    | 122  | ns            | $V_R = 400\text{ V}$ , $I_F = 8.7\text{ A}$ ,<br>$di_F/dt = 100\text{ A}/\mu\text{s}$ ; see table 8 |
| Reverse recovery charge       | $Q_{rr}$  |        | 0.48  | 0.72 | $\mu\text{C}$ |                                                                                                     |
| Peak reverse recovery current | $I_{rrm}$ |        | 10.20 | -    | A             |                                                                                                     |

## 4 Electrical characteristics diagrams

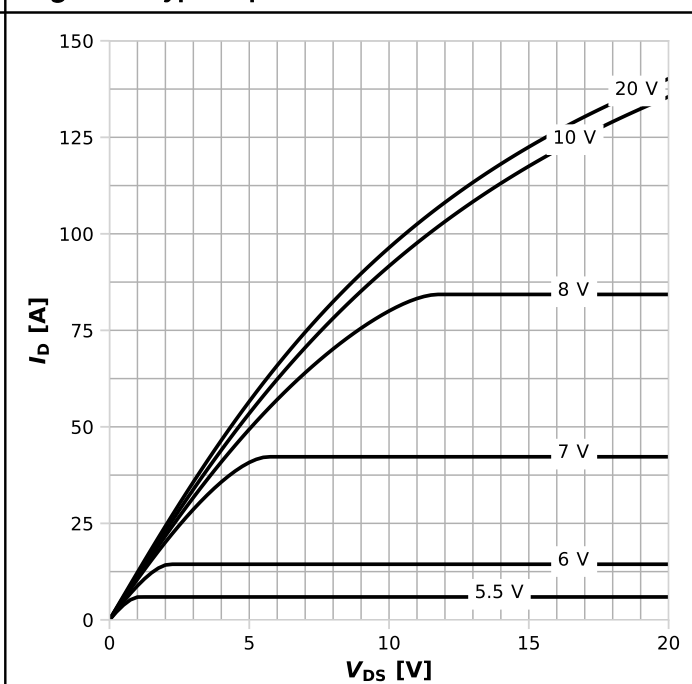


**Diagram 5: Typ. output characteristics**



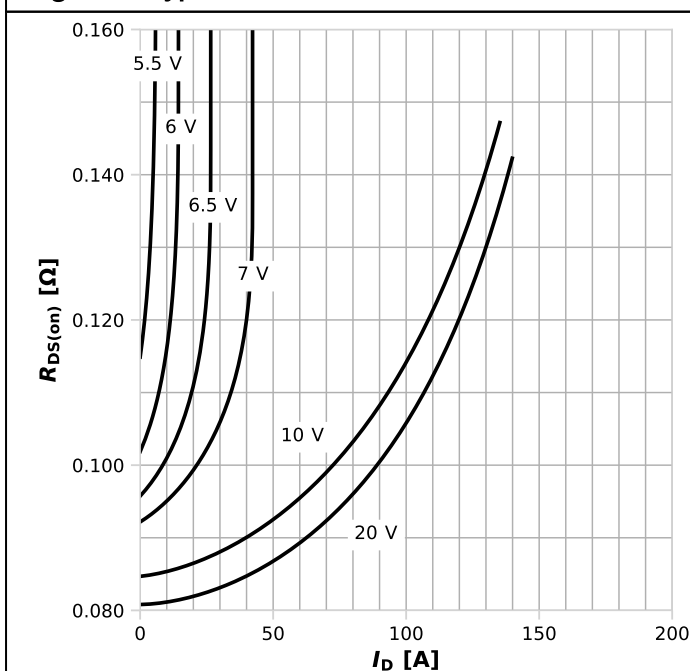
$I_D = f(V_{DS}); T_j = 25^\circ\text{C}; \text{parameter: } V_{GS}$

**Diagram 6: Typ. output characteristics**



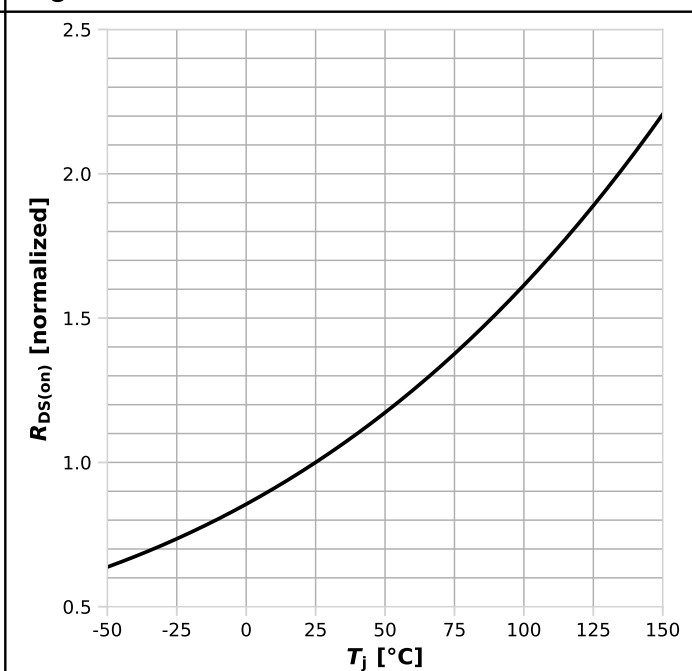
$I_D = f(V_{DS}); T_j = 125^\circ\text{C}; \text{parameter: } V_{GS}$

**Diagram 7: Typ. drain-source on-state resistance**



$R_{DS(on)} = f(I_D); T_j = 125^\circ\text{C}; \text{parameter: } V_{GS}$

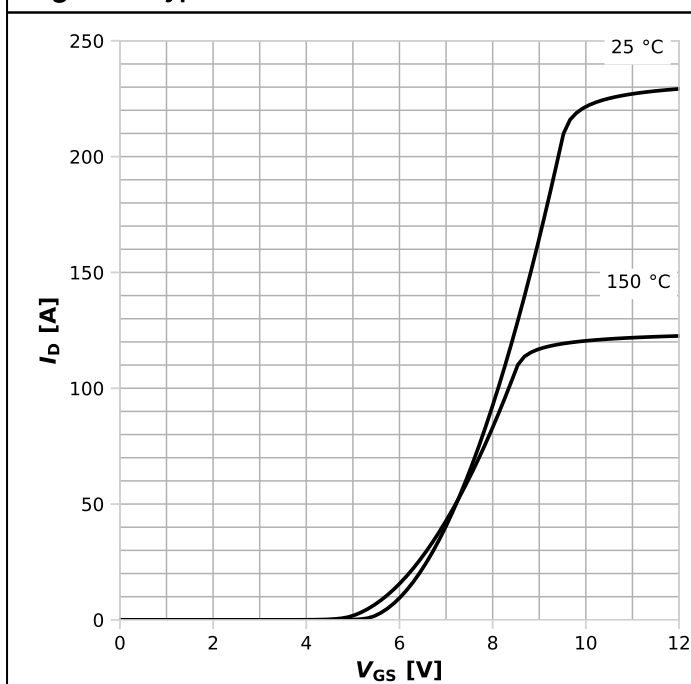
**Diagram 8: Drain-source on-state resistance**



$R_{DS(on)} = f(T_j); I_D = 18.2 \text{ A}; V_{GS} = 10 \text{ V}$

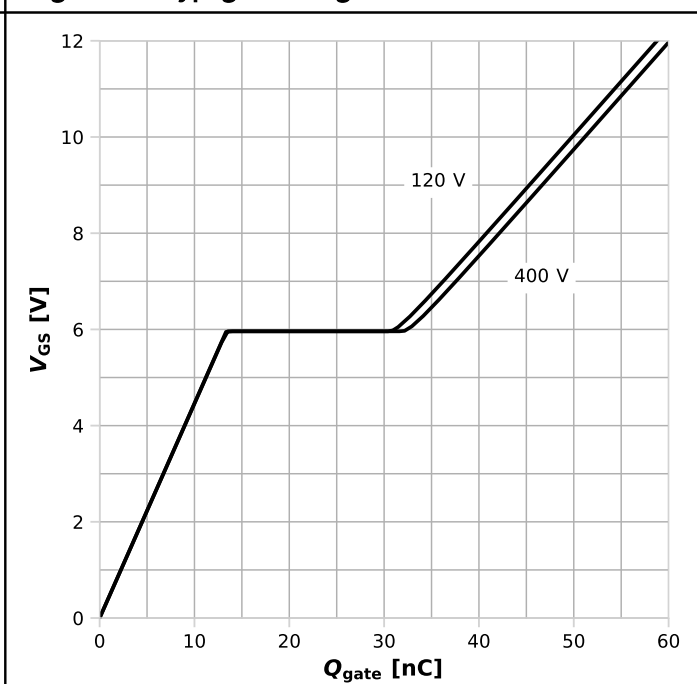


Diagram 9: Typ. transfer characteristics



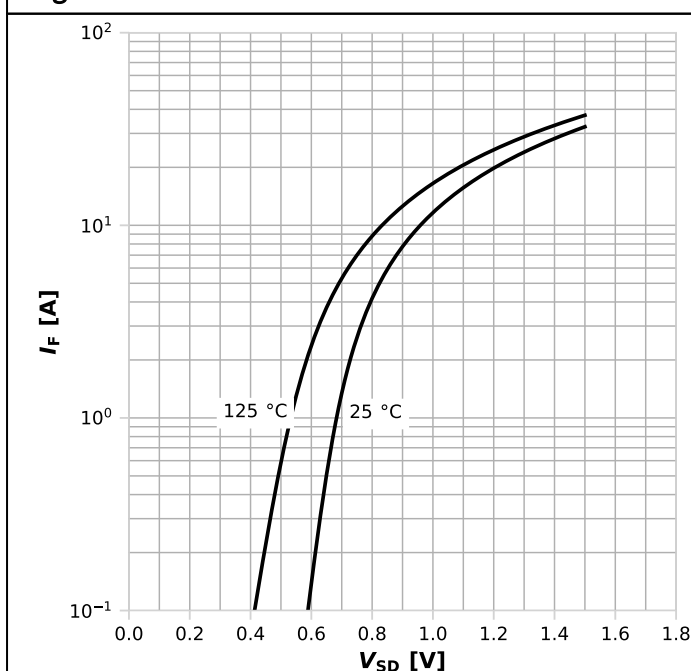
$I_D = f(V_{GS})$ ;  $V_{DS} = 20$  V; parameter:  $T_j$

Diagram 10: Typ. gate charge



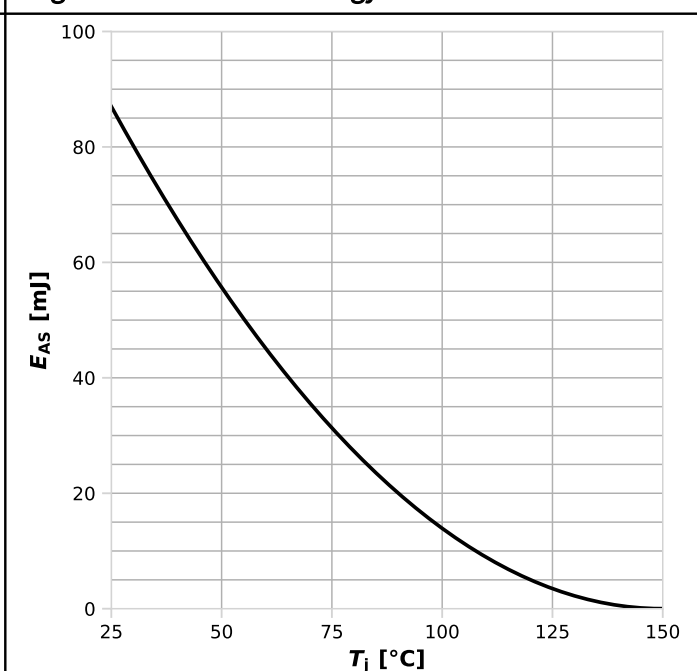
$V_{GS} = f(Q_{gate})$ ;  $I_D = 8.7$  A pulsed; parameter:  $V_{DD}$

Diagram 11: Forward characteristics of reverse diode



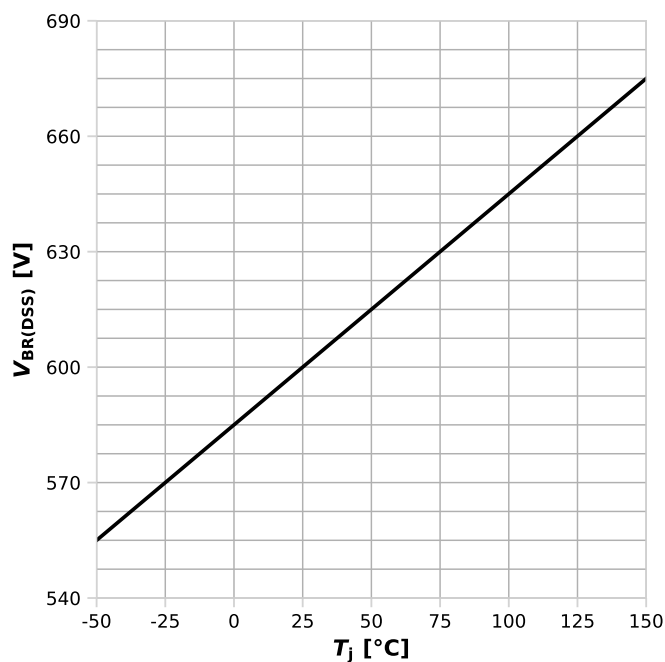
$I_F = f(V_{SD})$ ; parameter:  $T_j$

Diagram 12: Avalanche energy



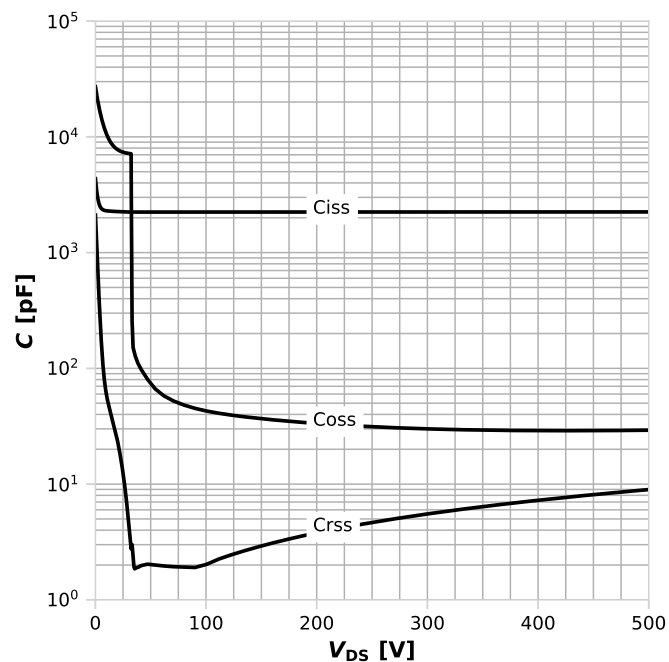
$E_{AS} = f(T_j)$ ;  $I_D = 3.9$  A;  $V_{DD} = 50$  V

**Diagram 13: Drain-source breakdown voltage**



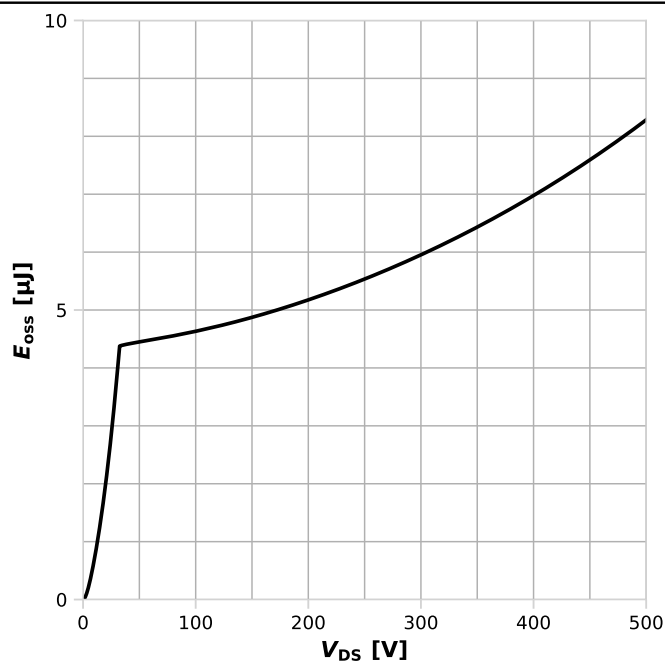
$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$

**Diagram 14: Typ. capacitances**



$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 250 \text{ kHz}$$

**Diagram 15: Typ. Coss stored energy**



$$E_{oss} = f(V_{DS})$$

5 Test circuits

Table 8 Diode characteristics

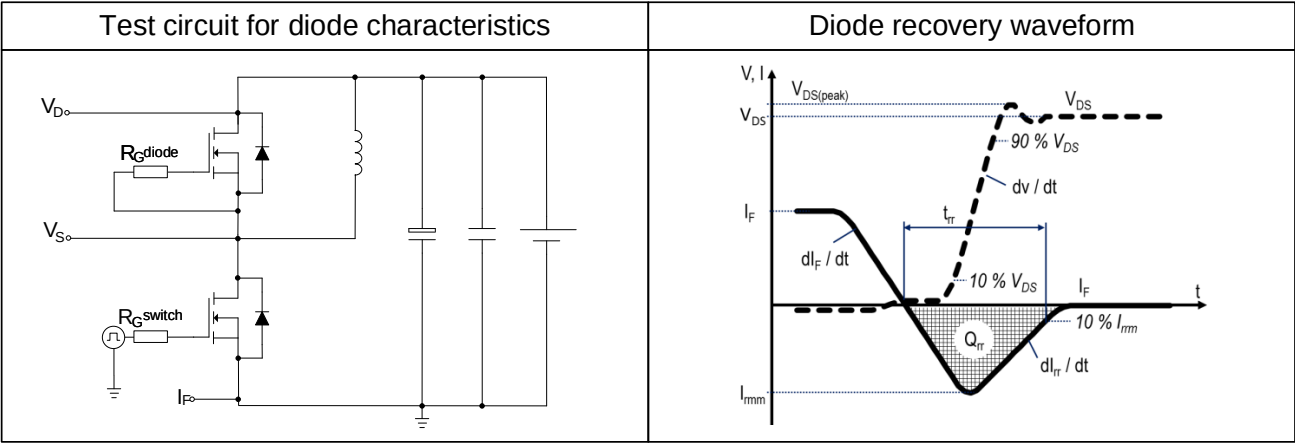


Table 9 Switching times (ss)

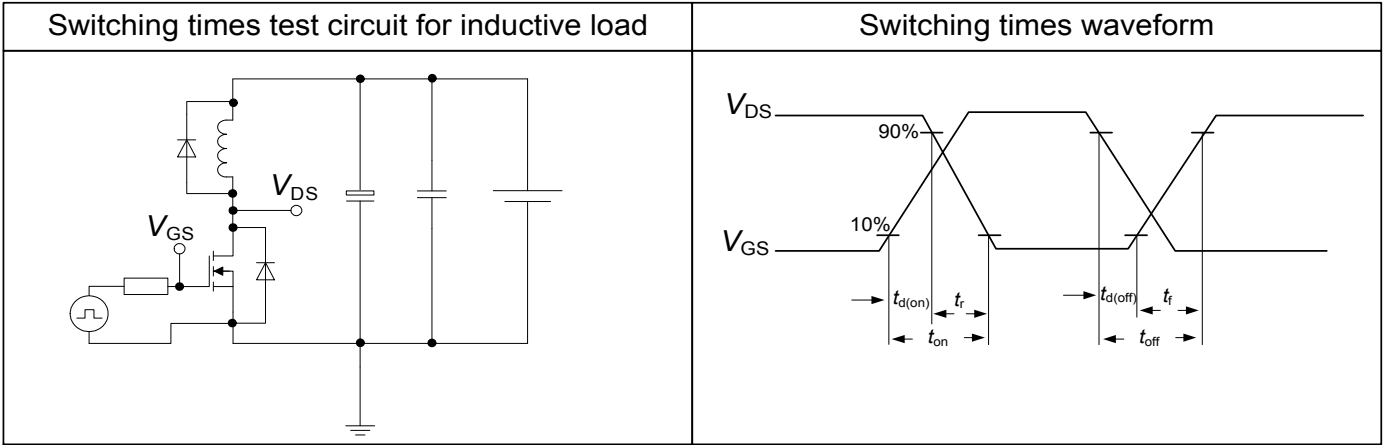
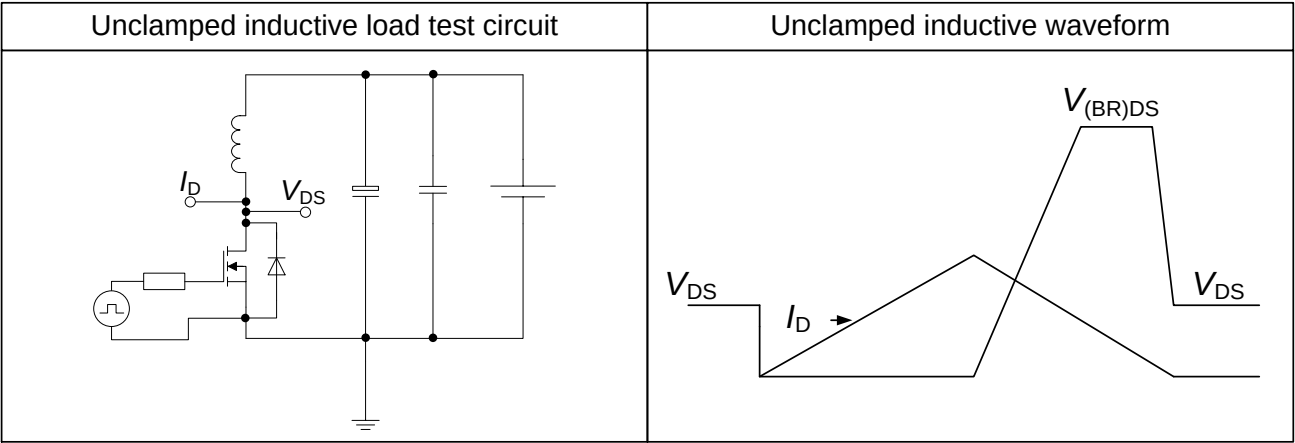
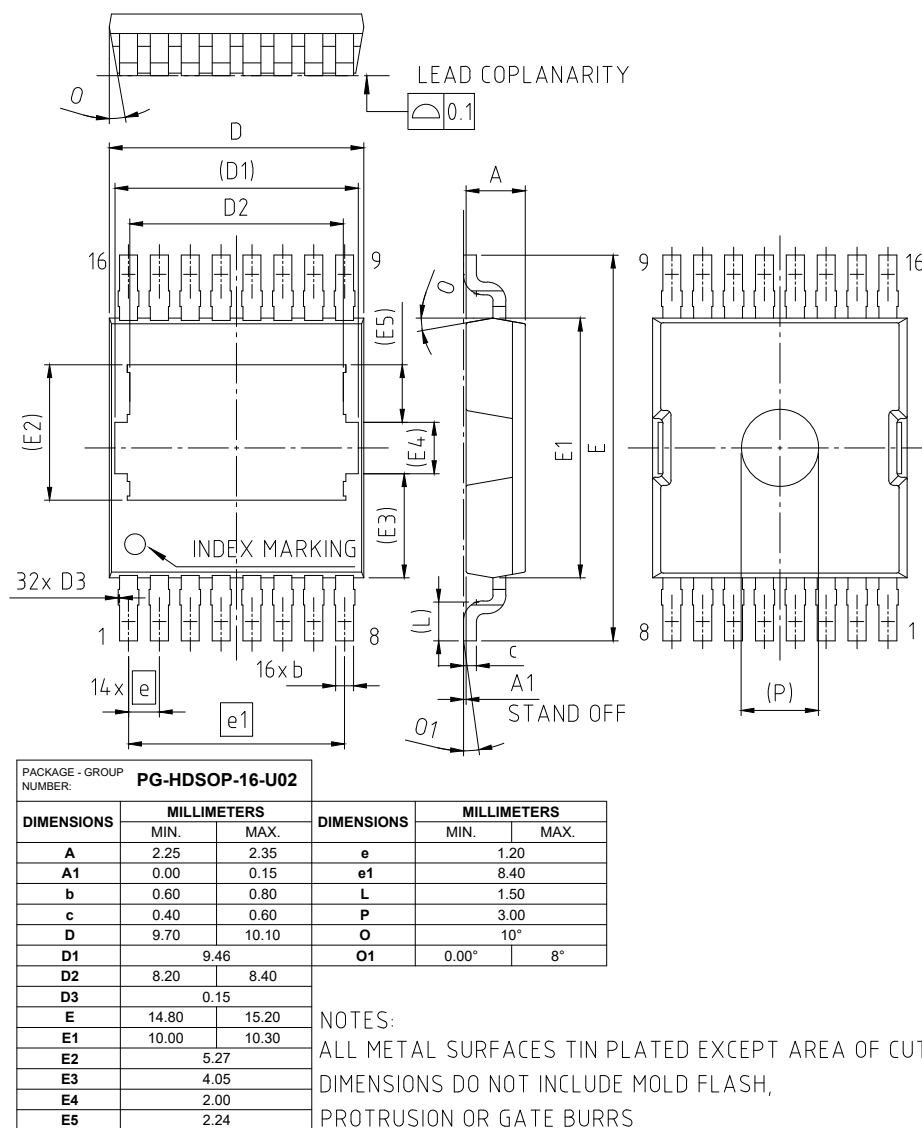


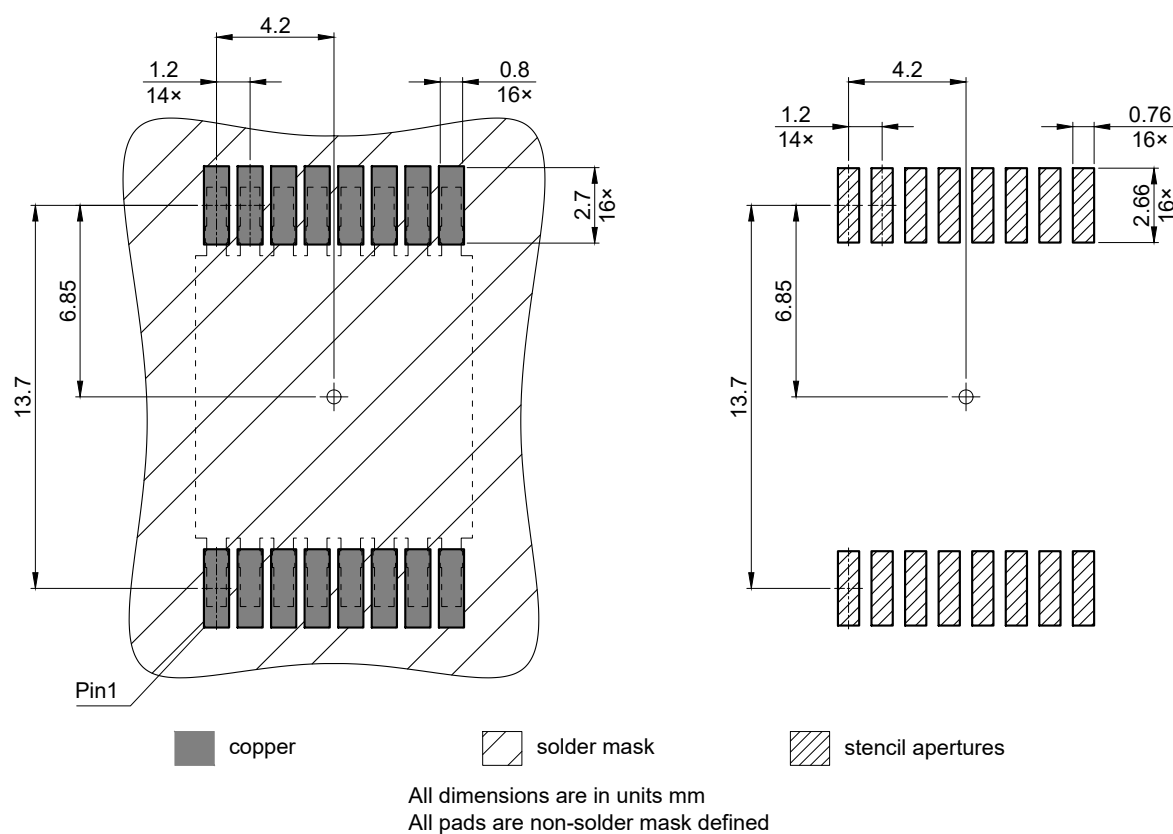
Table 10 Unclamped inductive load (ss)



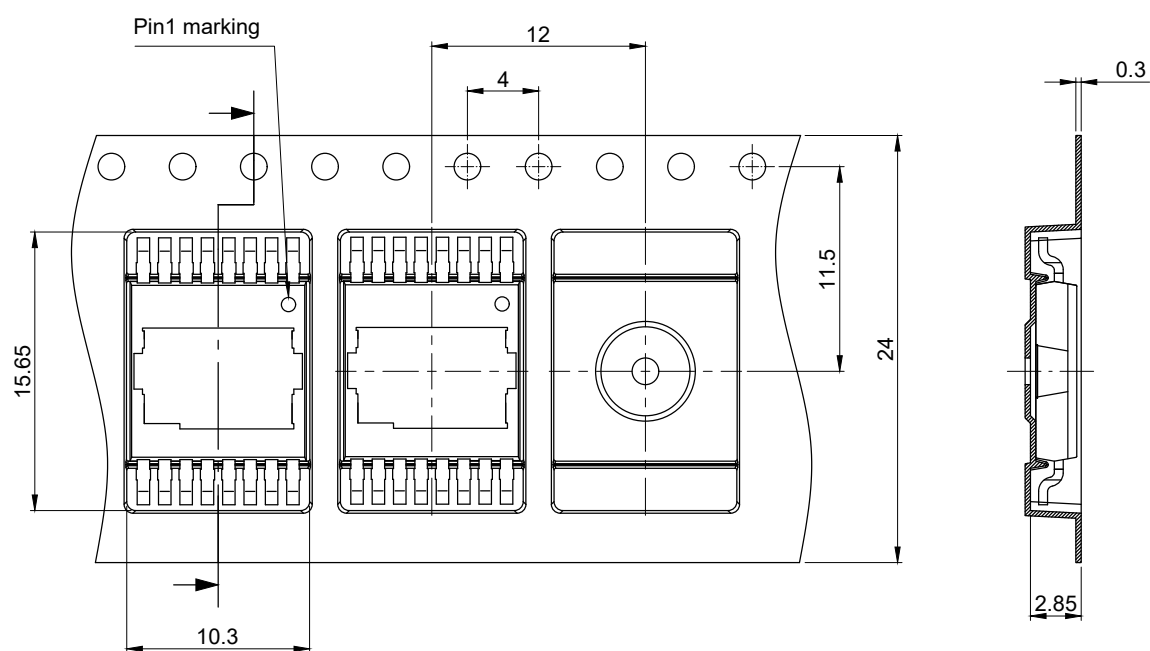
## 6 Package outlines



**Figure 1** Outline PG-HDSOP-16, dimensions in mm



**Figure 2 Footprint drawing PG-HDSOP-16, dimensions in mm**



All dimensions are in units mm

The drawing is in compliance with ISO 128-30, Projection Method 1 [  ]

**Figure 3** Packaging variant PG-HDSOP-16, dimensions in mm

## 7 Appendix A

**Table 11**    **Related links**

- [IFX CoolMOS CM8 Webpage](#)
- [IFX CoolMOS CM8 application note](#)
- [IFX CoolMOS CM8 simulation model](#)
- [IFX Design tools](#)

**Revision history**

IPLT60R055CM8

**Revision 2025-11-18, Rev. 2.0**

Previous revisions

| Revision | Date       | Subjects (major changes since last revision) |
|----------|------------|----------------------------------------------|
| 2.0      | 2025-11-18 | Release of final version                     |



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